

SSC8322GN2

Dual N-Channel Enhancement Mode MOSFET

> Features

VDS	VGS	RDSON Typ.	ID
201/	±12V	40mR@4V5	4.40
20V		50mR@2V5	4.4A

Description

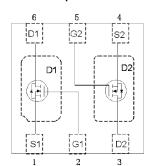
SSC8322GN2 combines 2 N-Channel enhancement mode power MOSFETs which are produced with high cell density and DMOS trench technology. This device particularly suits low voltage applications, especially for battery powered circuits, the tiny and thin outline saves PCB consumption

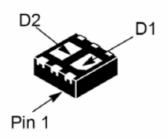
Applications

- Li Battery Charging
- High Side DC/DC Converter
- Load Switch
- Powered Devices
- Power Management in Portable,
 Battery

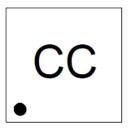
> Pin configuration

Top view





Bottom View



Marking

Ordering Information

Device	Package Shippin	
SSC8322GN2	DFN2x2	3000/Reel



➤ Absolute Maximum Ratings(T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V_{DSS}	Drain-to-Source Voltage	20	V	
V_{GSS}	Gate-to-Source Voltage	±12	V	
I _D	Continuous Drain Current ^a	4.4	Α	
I _{DM}	Pulsed Drain Current ^b	22	Α	
P _D	Power Dissipation ^c	2.2	W	
P _{DSM}	Power Dissipation ^a	1.1	W	
TJ	Operation junction temperature	-55 to 150	°C	
T_{STG}	Storage temperature range	-55 to 150	°C	

➤ Thermal Resistance Ratings($T_A=25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Typical	Maximum	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance ^a		120	°C/W
$R_{ heta JC}$	Junction-to-Case Thermal Resistance		60	C/VV

Note:

- a. The value of RθJA is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with TA=25℃. The value in any given application depends on the user is specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation PD is based on TJ(MAX)=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

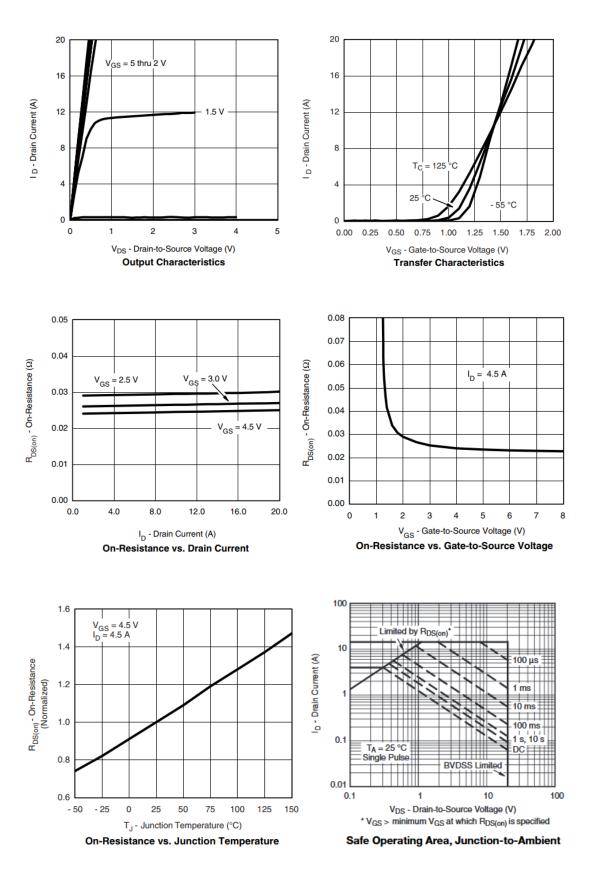


➤ Electronics Characteristics(T_A=25°C unless otherwise noted)

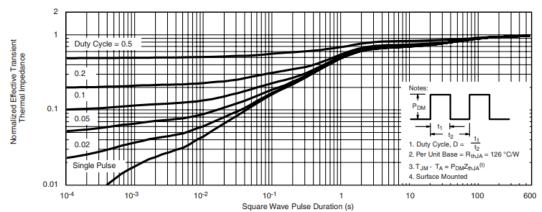
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit	
V _{(BR)DSS}	Drain-Source Breakdown Voltage	VGS=0V , ID=250uA	20			V	
V _{GS (th)}	Gate Threshold Voltage	VDS=VGS , ID=250uA	0.4	0.7	1.2	V	
-	Drain-Source On-	VGS=4.5V , ID=3.6A		40	60	mR	
$R_{DS(on)}$	Resistance	VGS=2.5V , ID=3.1A		50	80		
I _{DSS}	Zero Gate Voltage Drain Current	VDS=20V , VGS=0V			1	uA	
I _{GSS}	Gate-Source leak	VGS=±12V , VDS=0V			±100	nA	
V_{SD}	Forward Voltage	VGS=0V , IS=1.1A		8.0	1.15	V	
G_{FS}	Transconductance	VDS=5V , ID=3.6A		13		S	
Ciss	Input Capacitance	VDS=10V , VGS=0V , f=1MHz		450			
Coss	Output Capacitance			70		pF	
Crss	Reverse Transfer Capacitance			43			
Qg	Total Gate charge			3			
Qgs	Gate to Source charge	VGS=4.5V , VDS=15V , ID=3A		0.6		nC	
Qgd	Gate to Drain charge			1.1			
$T_{D(ON)}$	Turn-on delay time			15			
Tr	Rise time	VGS=4.5V,		18			
$T_{D(OFF)}$	Turn-off delay time	VDS=5V, RG=6R,ID=3.6A		60		ns	
Tf	Fall time			20			



➤ Typical Characteristics(T_A=25°C unless otherwise noted)



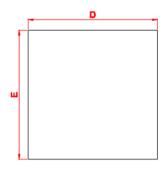


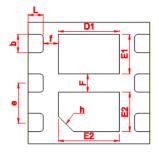


Normalized Thermal Transient Impedance, Junction-to-Ambient



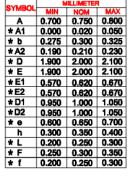
Package Information

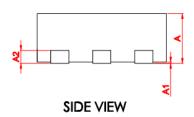




TOP VIEW

BOTTOM VIEW





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